

Notice of References Cited		Application/Control No. 10/711,940	Applicant(s)/Patent Under Reexamination HENINGER ET AL.	
		Examiner BENJAMIN E. LANIER	Art Unit 2132	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,957,276	10-2005	Bahl, Pradeep	709/245
*	B	US-7,047,314	05-2006	Sato et al.	709/238
*	C	US-6,801,507	10-2004	Humbleman et al.	370/257
*	D	US-6,832,322	12-2004	Boden et al.	726/15
*	E	US-6,738,377	05-2004	Boden, Edward B.	370/392
*	F	US-2005/0076142	04-2005	Chin, Kwan Wu	709/245
*	G	US-2004/0218611	11-2004	Kim, Jun-hyeong	370/401
*	H	US-7,028,333	04-2006	Tuomenoksa et al.	726/3
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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